

74AHC259; 74AHCT259

8-bit addressable latch

Rev. 02 — 15 May 2008

Product data sheet

1. General description

The 74AHC259; 74AHCT259 is a high-speed Si-gate CMOS device and is pin compatible with Low-power Schottky TTL (LSTTL). It is specified in compliance with JEDEC standard No. 7-A.

The 74AHC259; 74AHCT259 is a high-speed 8-bit addressable latch designed for general purpose storage applications in digital systems. It is a multifunctional device capable of storing single-line data in eight addressable latches and providing a 3-to-8 decoder and multiplexer function with active HIGH outputs (Q0 to Q7). It also incorporates an active LOW common reset (\overline{MR}) for resetting all latches as well as an active LOW enable input (\overline{LE}).

The 74AHC259; 74AHCT259 has four modes of operation:

- In the addressable latch mode, data on the data line (D) is written into the addressed latch. The addressed latch will follow the data input with all non-addressed latches remaining in their previous states.
- In the memory mode, all latches remain in their previous states and are unaffected by the data or address inputs.
- In the 3-to-8 decoding or demultiplexing mode, the addressed output follows the state of the data input (D) with all other outputs in the LOW state.
- In the reset mode, all outputs are LOW and unaffected by the address inputs (A0 to A2) and data input (D).

When operating the 74AHC259; 74AHCT259 as an address latch, changing more than one bit of the address could impose a transient-wrong address. Therefore, this should only be done while in the memory mode.

2. Features

- Balanced propagation delays
- All inputs have Schmitt-trigger actions
- Combines demultiplexer and 8-bit latch
- Serial-to-parallel capability
- Output from each storage bit available
- Random (addressable) data entry
- Easily expandable
- Common reset input
- Useful as a 3-to-8 active HIGH decoder
- Inputs accept voltages higher than V_{CC}



- Input levels:
 - ◆ For 74AHC259: CMOS level
 - ◆ For 74AHCT259: TTL level
- ESD protection:
 - ◆ HBM EIA/JESD22-A114E exceeds 2000 V
 - ◆ MM EIA/JESD22-A115-A exceeds 200 V
 - ◆ CDM EIA/JESD22-C101C exceeds 1000 V
- Multiple package options
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

3. Ordering information

Table 1. Ordering information

| Type number | Package | | | Version |
|------------------|-------------------|---------|--|----------|
| | Temperature range | Name | Description | |
| 74AHC259 | | | | |
| 74AHC259D | -40 °C to +125 °C | SO16 | plastic small outline package; 16 leads; body width 3.9 mm | SOT109-1 |
| 74AHC259PW | -40 °C to +125 °C | TSSOP16 | plastic thin shrink small outline package; 16 leads; body width 4.4 mm | SOT403-1 |
| 74AHCT259 | | | | |
| 74AHCT259D | -40 °C to +125 °C | SO16 | plastic small outline package; 16 leads; body width 3.9 mm | SOT109-1 |
| 74AHCT259PW | -40 °C to +125 °C | TSSOP16 | plastic thin shrink small outline package; 16 leads; body width 4.4 mm | SOT403-1 |

4. Functional diagram

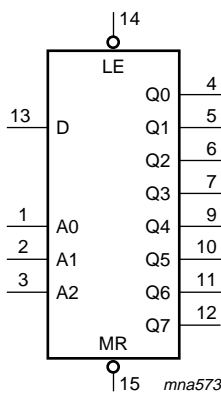


Fig 1. Logic symbol

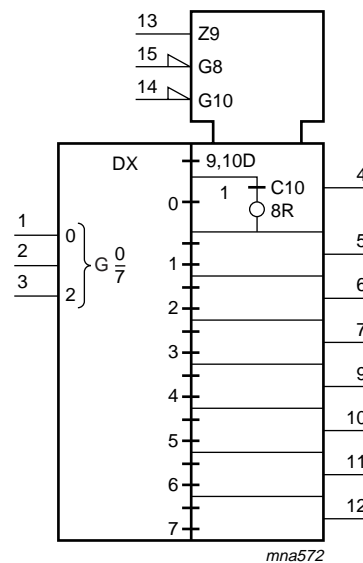


Fig 2. IEC logic symbol

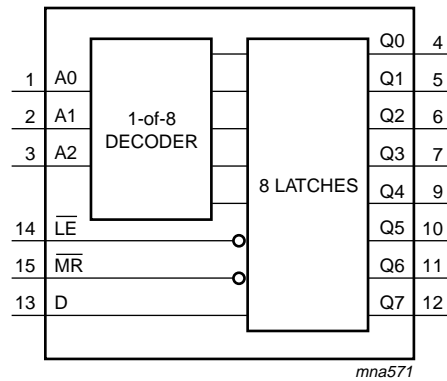


Fig 3. Functional diagram

5. Pinning information

5.1 Pinning

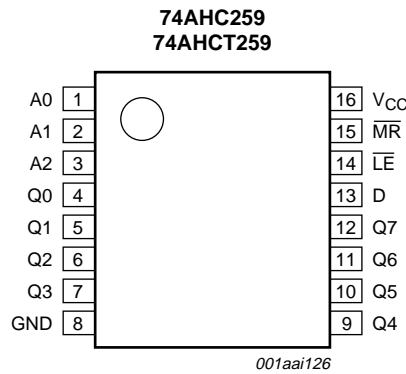


Fig 4. Pin configuration

5.2 Pin description

Table 2. Pin description

| Symbol | Pin | Description |
|--------|-----|---------------|
| A0 | 1 | address input |
| A1 | 2 | address input |
| A2 | 3 | address input |
| Q0 | 4 | latch output |
| Q1 | 5 | latch output |
| Q2 | 6 | latch output |
| Q3 | 7 | latch output |
| GND | 8 | ground (0 V) |
| Q4 | 9 | latch output |
| Q5 | 10 | latch output |

Table 2. Pin description ...continued

| Symbol | Pin | Description |
|-----------------|-----|--------------------------------------|
| Q6 | 11 | latch output |
| Q7 | 12 | latch output |
| D | 13 | data input |
| \overline{LE} | 14 | latch enable input (active LOW) |
| \overline{MR} | 15 | conditional reset input (active LOW) |
| V _{CC} | 16 | supply voltage |

6. Functional description

Table 3. Function table^[1]

| Operating mode | Input | | | | | | Output | | | | | | | |
|--|-------|----|---|----|----|----|----------------|----------------|----------------|----------------|----------------|----------------|----------------|----------------|
| | MR | LE | D | A0 | A1 | A2 | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 | Q6 | Q7 |
| Reset (clear) | L | H | X | X | X | X | L | L | L | L | L | L | L | L |
| Demultiplexer (active HIGH 8-channel) decoder (when D = H) | L | L | d | L | L | L | Q = d | L | L | L | L | L | L | L |
| | | | d | H | L | L | L | Q = d | L | L | L | L | L | L |
| | | | d | L | H | L | L | L | Q = d | L | L | L | L | L |
| | | | d | H | H | L | L | L | Q = d | L | L | L | L | L |
| | | | d | L | L | H | L | L | L | Q = d | L | L | L | L |
| | | | d | H | L | H | L | L | L | Q = d | L | L | L | L |
| | | | d | L | H | H | L | L | L | L | L | L | Q = d | L |
| | | | d | H | H | H | L | L | L | L | L | L | L | L |
| Memory (no action) | H | H | X | X | X | X | q ₀ | q ₁ | q ₂ | q ₃ | q ₄ | q ₅ | q ₆ | q ₇ |
| Addressable latch | H | L | d | L | L | L | Q = d | q ₁ | q ₂ | q ₃ | q ₄ | q ₅ | q ₆ | q ₇ |
| | | | d | H | L | L | q ₀ | Q = d | q ₂ | q ₃ | q ₄ | q ₅ | q ₆ | q ₇ |
| | | | d | L | H | L | q ₀ | q ₁ | Q = d | q ₃ | q ₄ | q ₅ | q ₆ | q ₇ |
| | | | d | H | H | L | q ₀ | q ₁ | q ₂ | Q = d | q ₄ | q ₅ | q ₆ | q ₇ |
| | | | d | L | L | H | q ₀ | q ₁ | q ₂ | q ₃ | Q = d | q ₅ | q ₆ | q ₇ |
| | | | d | H | L | H | q ₀ | q ₁ | q ₂ | q ₃ | q ₄ | Q = d | q ₆ | q ₇ |
| | | | d | L | H | H | q ₀ | q ₁ | q ₂ | q ₃ | q ₄ | q ₅ | Q = d | q ₇ |
| | | | H | H | H | H | q ₀ | q ₁ | q ₂ | q ₃ | q ₄ | q ₅ | q ₆ | Q = d |

[1] H = HIGH voltage level;
 L = LOW voltage level;
 X = don't care;
 d = HIGH or LOW data one set-up time prior to the LOW-to-HIGH \overline{LE} transition;
 q = lower case letter indicates the state of the referenced input one set-up time prior to the LOW-to-HIGH transition.

Table 4. Operating mode select table^[1]

| LE | MR | Mode |
|----|----|-------------------------------------|
| L | H | addressable latch |
| H | H | memory |
| L | L | active HIGH 8-channel demultiplexer |
| H | L | reset |

[1] H = HIGH voltage level; L = LOW voltage level.

7. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|-------------------------|---|---------|------|------|
| V _{CC} | supply voltage | | -0.5 | +7.0 | V |
| V _I | input voltage | | -0.5 | +7.0 | V |
| I _{IK} | input clamping current | V _I < -0.5 V | [1] -20 | - | mA |
| I _{OK} | output clamping current | V _O < -0.5 V or V _O > V _{CC} + 0.5 V | [1] -20 | +20 | mA |
| I _O | output current | V _O = -0.5 V to (V _{CC} + 0.5 V) | -25 | +25 | mA |
| I _{CC} | supply current | | - | +75 | mA |
| I _{GND} | ground current | | -75 | - | mA |
| T _{stg} | storage temperature | | -65 | +150 | °C |
| P _{tot} | total power dissipation | T _{amb} = -40 °C to +125 °C | [2] - | 500 | mW |

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] For SO16 packages: above 70 °C the value of P_{tot} derates linearly at 8 mW/K.
For TSSOP16 packages: above 60 °C the value of P_{tot} derates linearly at 5.5 mW/K.

8. Recommended operating conditions

Table 6. Operating conditions

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|------------------|-------------------------------------|----------------------------------|-----|-----|-----------------|------|
| 74AHC259 | | | | | | |
| V _{CC} | supply voltage | | 2.0 | 5.0 | 5.5 | V |
| V _I | input voltage | | 0 | - | 5.5 | V |
| V _O | output voltage | | 0 | - | V _{CC} | V |
| T _{amb} | ambient temperature | | -40 | +25 | +125 | °C |
| Δt/ΔV | input transition rise and fall rate | V _{CC} = 3.0 V to 3.6 V | - | - | 100 | ns/V |
| | | V _{CC} = 4.5 V to 5.5 V | - | - | 20 | ns/V |
| 74AHCT259 | | | | | | |
| V _{CC} | supply voltage | | 4.5 | 5.0 | 5.5 | V |
| V _I | input voltage | | 0 | - | 5.5 | V |
| V _O | output voltage | | 0 | - | V _{CC} | V |
| T _{amb} | ambient temperature | | -40 | +25 | +125 | °C |
| Δt/ΔV | input transition rise and fall rate | V _{CC} = 4.5 V to 5.5 V | - | - | 20 | ns/V |

9. Static characteristics

Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | 25 °C | | | -40 °C to +85 °C | | -40 °C to +125 °C | | Unit |
|------------------|---------------------------|--|-------|-----|------|------------------|------|-------------------|------|------|
| | | | Min | Typ | Max | Min | Max | Min | Max | |
| 74AHC259 | | | | | | | | | | |
| V _{IH} | HIGH-level input voltage | V _{CC} = 2.0 V | 1.5 | - | - | 1.5 | - | 1.5 | - | V |
| | | V _{CC} = 3.0 V | 2.1 | - | - | 2.1 | - | 2.1 | - | V |
| | | V _{CC} = 5.5 V | 3.85 | - | - | 3.85 | - | 3.85 | - | V |
| V _{IL} | LOW-level input voltage | V _{CC} = 2.0 V | - | - | 0.5 | - | 0.5 | - | 0.5 | V |
| | | V _{CC} = 3.0 V | - | - | 0.9 | - | 0.9 | - | 0.9 | V |
| | | V _{CC} = 5.5 V | - | - | 1.65 | - | 1.65 | - | 1.65 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} | | | | | | | | |
| | | I _O = -50 µA; V _{CC} = 2.0 V | 1.9 | 2.0 | - | 1.9 | - | 1.9 | - | V |
| | | I _O = -50 µA; V _{CC} = 3.0 V | 2.9 | 3.0 | - | 2.9 | - | 2.9 | - | V |
| | | I _O = -50 µA; V _{CC} = 4.5 V | 4.4 | 4.5 | - | 4.4 | - | 4.4 | - | V |
| | | I _O = -4.0 mA; V _{CC} = 3.0 V | 2.58 | - | - | 2.48 | - | 2.40 | - | V |
| | | I _O = -8.0 mA; V _{CC} = 4.5 V | 3.94 | - | - | 3.80 | - | 3.70 | - | V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} | | | | | | | | |
| | | I _O = 50 µA; V _{CC} = 2.0 V | - | 0 | 0.1 | - | 0.1 | - | 0.1 | V |
| | | I _O = 50 µA; V _{CC} = 3.0 V | - | 0 | 0.1 | - | 0.1 | - | 0.1 | V |
| | | I _O = 50 µA; V _{CC} = 4.5 V | - | 0 | 0.1 | - | 0.1 | - | 0.1 | V |
| | | I _O = 4.0 mA; V _{CC} = 3.0 V | - | - | 0.36 | - | 0.44 | - | 0.55 | V |
| | | I _O = 8.0 mA; V _{CC} = 4.5 V | - | - | 0.36 | - | 0.44 | - | 0.55 | V |
| I _I | input leakage current | V _I = 5.5 V or GND; V _{CC} = 0 V to 5.5 V | - | - | 0.1 | - | 1.0 | - | 2.0 | µA |
| I _{CC} | supply current | V _I = V _{CC} or GND; I _O = 0 A; V _{CC} = 5.5 V | - | - | 4.0 | - | 40 | - | 80 | µA |
| C _I | input capacitance | V _I = V _{CC} or GND | - | 3 | 10 | - | 10 | - | 10 | pF |
| C _O | output capacitance | | - | 4 | - | - | - | - | - | pF |
| 74AHCT259 | | | | | | | | | | |
| V _{IH} | HIGH-level input voltage | V _{CC} = 4.5 V to 5.5 V | 2.0 | - | - | 2.0 | - | 2.0 | - | V |
| V _{IL} | LOW-level input voltage | V _{CC} = 4.5 V to 5.5 V | - | - | 0.8 | - | 0.8 | - | 0.8 | V |
| V _{OH} | HIGH-level output voltage | V _I = V _{IH} or V _{IL} ; V _{CC} = 4.5 V | | | | | | | | |
| | | I _O = -50 µA | 4.4 | 4.5 | - | 4.4 | - | 4.4 | - | V |
| | | I _O = -8.0 mA | 3.94 | - | - | 3.80 | - | 3.70 | - | V |
| V _{OL} | LOW-level output voltage | V _I = V _{IH} or V _{IL} ; V _{CC} = 4.5 V | | | | | | | | |
| | | I _O = 50 µA | - | 0 | 0.1 | - | 0.1 | - | 0.1 | V |
| | | I _O = 8.0 mA | - | - | 0.36 | - | 0.44 | - | 0.55 | V |

Table 7. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | 25 °C | | | -40 °C to +85 °C | | -40 °C to +125 °C | | Unit |
|------------------|---------------------------|---|-------|-----|------|------------------|-----|-------------------|-----|------|
| | | | Min | Typ | Max | Min | Max | Min | Max | |
| I _I | input leakage current | V _I = 5.5 V or GND; V _{CC} = 0 V to 5.5 V | - | - | 0.1 | - | 1.0 | - | 2.0 | μA |
| I _{CC} | supply current | V _I = V _{CC} or GND; I _O = 0 A; V _{CC} = 5.5 V | - | - | 4.0 | - | 40 | - | 80 | μA |
| ΔI _{CC} | additional supply current | per input pin; V _I = V _{CC} - 2.1 V; other pins at V _{CC} or GND; I _O = 0 A; V _{CC} = 4.5 V to 5.5 V | - | - | 1.35 | - | 1.5 | - | 1.5 | mA |
| C _I | input capacitance | V _I = V _{CC} or GND | - | 3 | 10 | - | 10 | - | 10 | pF |
| C _O | output capacitance | | - | 4 | - | - | - | - | - | pF |

10. Dynamic characteristics

Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 11](#).

| Symbol | Parameter | Conditions | 25 °C | | | -40 °C to +85 °C | | -40 °C to +125 °C | | Unit |
|-----------------|-------------------|---|-------|--------------------|------|------------------|------|-------------------|------|------|
| | | | Min | Typ ^[1] | Max | Min | Max | Min | Max | |
| 74AHC259 | | | | | | | | | | |
| t _{pd} | propagation delay | D to Qn; see Figure 5 ^[2] | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | | | | | | | | |
| | | C _L = 15 pF | - | 5.8 | 11.5 | 1.0 | 13.5 | 1.0 | 15.0 | ns |
| | | C _L = 50 pF | - | 7.3 | 14.5 | 1.0 | 17.0 | 1.0 | 18.5 | ns |
| | | V _{CC} = 4.5 V to 5.5 V | | | | | | | | |
| | | C _L = 15 pF | - | 4.1 | 7.5 | 1.0 | 9.0 | 1.0 | 10.0 | ns |
| | | C _L = 50 pF | - | 5.3 | 9.5 | 1.0 | 11.0 | 1.0 | 12.0 | ns |
| | | An to Qn; see Figure 6 ^[2] | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | | | | | | | | |
| | | C _L = 15 pF | - | 7.5 | 14.5 | 1.0 | 17.0 | 1.0 | 18.5 | ns |
| | | C _L = 50 pF | - | 9.1 | 18.0 | 1.0 | 21.0 | 1.0 | 23.0 | ns |
| | | V _{CC} = 4.5 V to 5.5 V | | | | | | | | |
| | | C _L = 15 pF | - | 5.3 | 9.5 | 1.0 | 11.5 | 1.0 | 12.5 | ns |
| | | C _L = 50 pF | - | 6.5 | 11.5 | 1.0 | 13.5 | 1.0 | 15.0 | ns |
| | | LE to Qn; see Figure 7 ^[2] | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | | | | | | | | |
| | | C _L = 15 pF | - | 6.2 | 12.0 | 1.0 | 14.0 | 1.0 | 15.2 | ns |
| | | C _L = 50 pF | - | 7.7 | 15.5 | 1.0 | 17.5 | 1.0 | 19.0 | ns |
| | | V _{CC} = 4.5 V to 5.5 V | | | | | | | | |
| | | C _L = 50 pF | - | 5.5 | 10.0 | 1.0 | 11.5 | 1.0 | 12.5 | ns |

Table 8. Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 11](#).

| Symbol | Parameter | Conditions | 25 °C | | | -40 °C to +85 °C | | -40 °C to +125 °C | | Unit | |
|-----------------|-------------------------------|---|-------|--------------------|------|------------------|------|-------------------|------|------|--|
| | | | Min | Typ ^[1] | Max | Min | Max | Min | Max | | |
| t _{pd} | propagation delay | \overline{MR} to Qn; see Figure 8 ^[3] | | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | | | | | | | | | |
| | | C _L = 15 pF | - | 5.4 | 10.5 | 1.0 | 12.5 | 1.0 | 13.5 | ns | |
| | | C _L = 50 pF | - | 7.0 | 13.5 | 1.0 | 15.5 | 1.0 | 17.0 | ns | |
| | | V _{CC} = 4.5 V to 5.5 V | | | | | | | | | |
| t _w | pulse width | \overline{LE} HIGH or LOW; see Figure 7 | | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | 5.0 | - | - | 5.0 | - | 5.0 | - | ns | |
| | | V _{CC} = 4.5 V to 5.5 V | 5.0 | - | - | 5.0 | - | 5.0 | - | ns | |
| | | \overline{MR} LOW; see Figure 8 | | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | 5.0 | - | - | 5.0 | - | 5.0 | - | ns | |
| t _{su} | set-up time | D, An to \overline{LE} ; see Figure 9 and Figure 10 | | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | 4.0 | - | - | 4.0 | - | 4.0 | - | ns | |
| | | V _{CC} = 4.5 V to 5.5 V | 4.0 | - | - | 4.0 | - | 4.0 | - | ns | |
| t _h | hold time | D, An to \overline{LE} ; see Figure 9 and Figure 10 | | | | | | | | | |
| | | V _{CC} = 3.0 V to 3.6 V | 1.0 | - | - | 1.0 | - | 1.0 | - | ns | |
| | | V _{CC} = 4.5 V to 5.5 V | 1.0 | - | - | 1.0 | - | 1.0 | - | ns | |
| C _{PD} | power dissipation capacitance | f _i = 1 MHz; V _I = GND to V _{CC} ^[4] | - | 13 | - | - | - | - | - | pF | |

74AHCT259; V_{CC} = 4.5 V to 5.5 V

| | | | | | | | | | | | |
|-----------------|--|--|-------------|---|------|-----|------|------|------|-----|---|
| t _{pd} | propagation delay | D to Qn; see Figure 5 ^[2] | | | | | | | | | |
| | | C _L = 15 pF | - | 4.1 | 7.5 | 1.0 | 9.0 | 1.0 | 10.0 | ns | |
| | | C _L = 50 pF | - | 5.4 | 9.5 | 1.0 | 11.0 | 1.0 | 12.0 | ns | |
| | An to Qn; see Figure 6 ^[2] | C _L = 15 pF | - | 5.5 | 9.5 | 1.0 | 11.5 | 1.0 | 12.5 | ns | |
| | | C _L = 50 pF | - | 6.6 | 12.0 | 1.0 | 14.0 | 1.0 | 15.5 | ns | |
| | | \overline{LE} to Qn; see Figure 7 ^[2] | | | | | | | | | |
| | C _L = 15 pF | - | 4.3 | 8.0 | 1.0 | 9.5 | 1.0 | 10.4 | ns | | |
| | | C _L = 50 pF | - | 5.5 | 10.0 | 1.0 | 12.0 | 1.0 | 13.0 | ns | |
| | \overline{MR} to Qn; see Figure 8 ^[3] | C _L = 15 pF | - | 3.9 | 7.0 | 1.0 | 8.5 | 1.0 | 9.5 | ns | |
| | | C _L = 50 pF | - | 5.1 | 9.0 | 1.0 | 10.5 | 1.0 | 11.5 | ns | |
| | | t _w | pulse width | \overline{LE} HIGH or LOW; see Figure 7 | 5.0 | - | - | 5.0 | - | 5.0 | - |
| | \overline{MR} LOW; see Figure 8 | 5.0 | | - | - | 5.0 | - | 5.0 | - | ns | |

Table 8. Dynamic characteristics ...continued

Voltages are referenced to GND (ground = 0 V); for test circuit see Figure 11.

| Symbol | Parameter | Conditions | 25 °C | | | -40 °C to +85 °C | | -40 °C to +125 °C | | Unit |
|-----------------|-------------------------------|--|-------|--------------------|-----|------------------|-----|-------------------|-----|------|
| | | | Min | Typ ^[1] | Max | Min | Max | Min | Max | |
| t _{su} | set-up time | D, An to \overline{LE} ; see Figure 9 and Figure 10 | 4.0 | - | - | 4.0 | - | 4.0 | - | ns |
| t _h | hold time | D, An to \overline{LE} ; see Figure 9 and Figure 10 | 1.0 | - | - | 1.0 | - | 1.0 | - | ns |
| C _{PD} | power dissipation capacitance | f _i = 1 MHz; V _I = GND to V _{CC} ^[4] | - | 17 | - | - | - | - | - | pF |

[1] Typical values are measured at nominal supply voltage (V_{CC} = 3.3 V and V_{CC} = 5.0 V).

[2] t_{pd} is the same as t_{PLH} and t_{PHL}.

[3] t_{pd} is the same as t_{PHL} only.

[4] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma(C_L \times V_{CC}^2 \times f_o) \text{ where:}$$

f_i = input frequency in MHz;

f_o = output frequency in MHz;

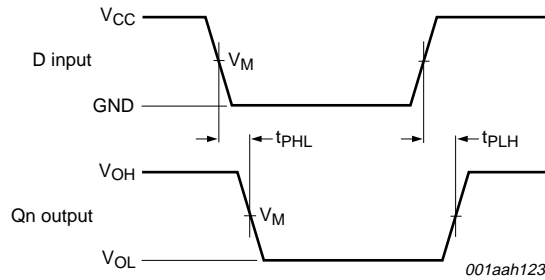
C_L = output load capacitance in pF;

V_{CC} = supply voltage in V;

N = number of inputs switching;

Σ(C_L × V_{CC}² × f_o) = sum of the outputs.

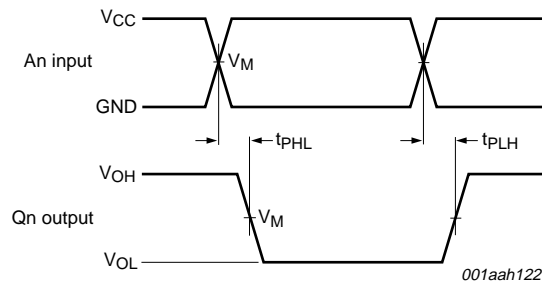
11. Waveforms



Measurement points are given in Table 9.

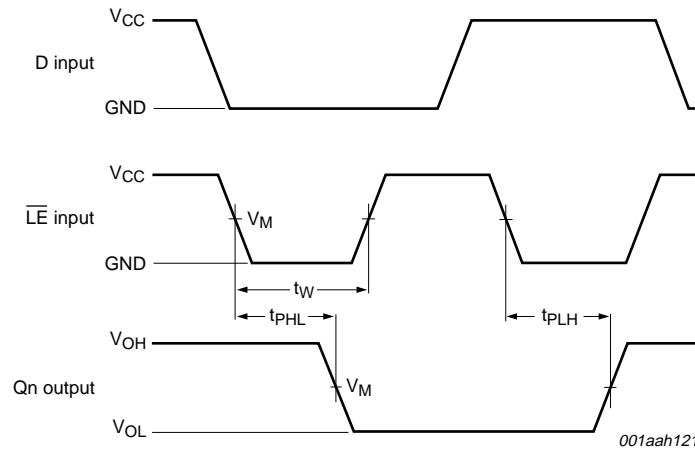
V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 5. Data input to output propagation delays



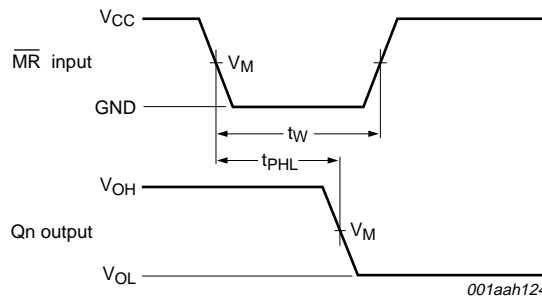
Measurement points are given in [Table 9](#).
 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 6. Address input to output propagation delays



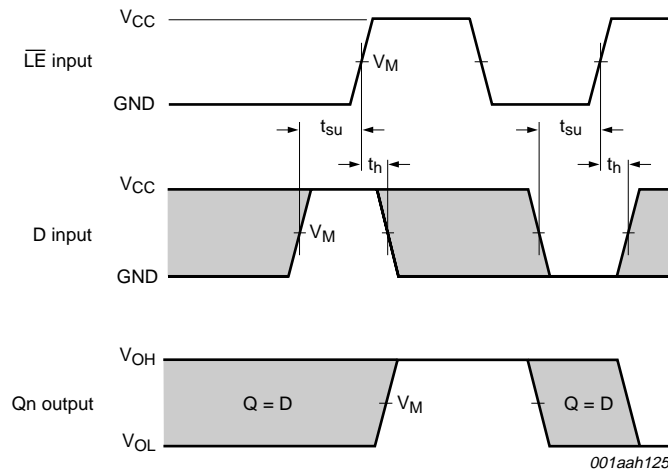
Measurement points are given in [Table 9](#).
 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 7. Enable input to output propagation delays and pulse width



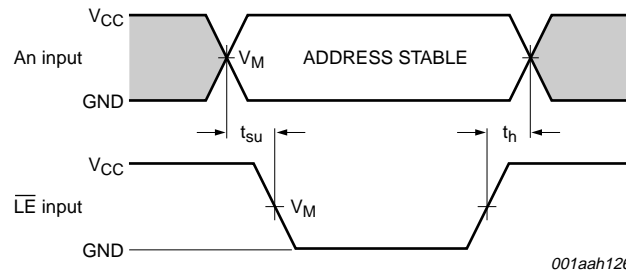
Measurement points are given in [Table 9](#).
 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 8. Conditional reset input to output propagation delays



Measurement points are given in [Table 9](#).
 The shaded areas indicate when the input is permitted to change for predictable output performance.
 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 9. Data input to latch enable input set-up and hold times

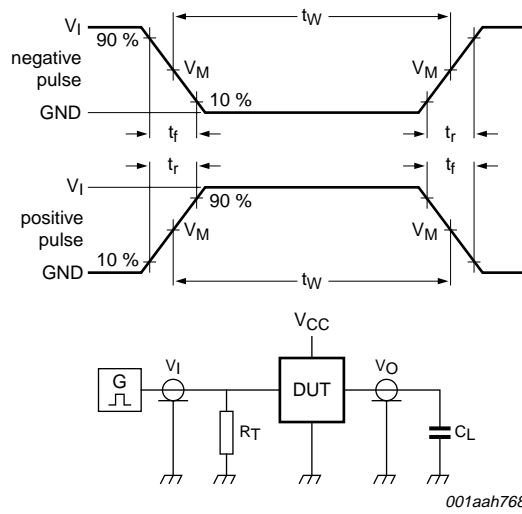


Measurement points are given in [Table 9](#).
 The shaded areas indicate when the input is permitted to change for predictable output performance.
 V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Fig 10. Address input to latch enable input set-up and hold times

Table 9. Measurement points

| Type | Input | Output |
|-----------|---------------------|---------------------|
| | V_M | V_M |
| 74AHC259 | $0.5 \times V_{CC}$ | $0.5 \times V_{CC}$ |
| 74AHCT259 | 1.5 V | $0.5 \times V_{CC}$ |



Test data is given in [Table 10](#).

Definitions test circuit:

R_T = termination resistance should be equal to output impedance Z_o of the pulse generator.

C_L = load capacitance including jig and probe capacitance.

Fig 11. Load circuitry for measuring switching times

Table 10. Test data

| Type | Input | | Load | Test |
|-----------|----------|---------------|--------------|--------------------|
| | V_I | t_r, t_f | C_L | |
| 74AHC259 | V_{CC} | ≤ 3.0 ns | 15 pF, 50 pF | t_{PLH}, t_{PHL} |
| 74AHCT259 | 3.0 V | ≤ 3.0 ns | 15 pF, 50 pF | t_{PLH}, t_{PHL} |

12. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1

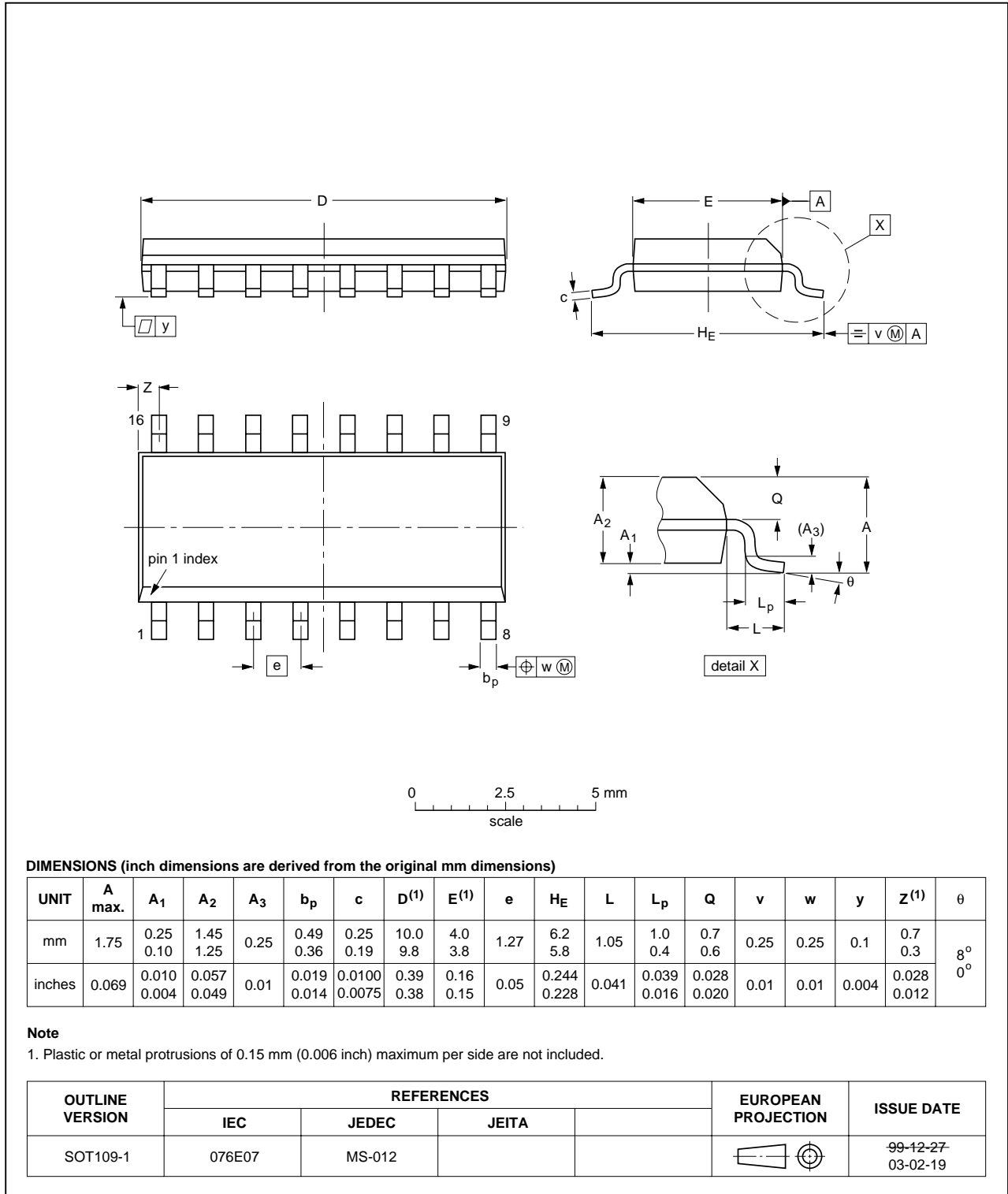


Fig 12. Package outline SOT109-1 (SO16)

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1

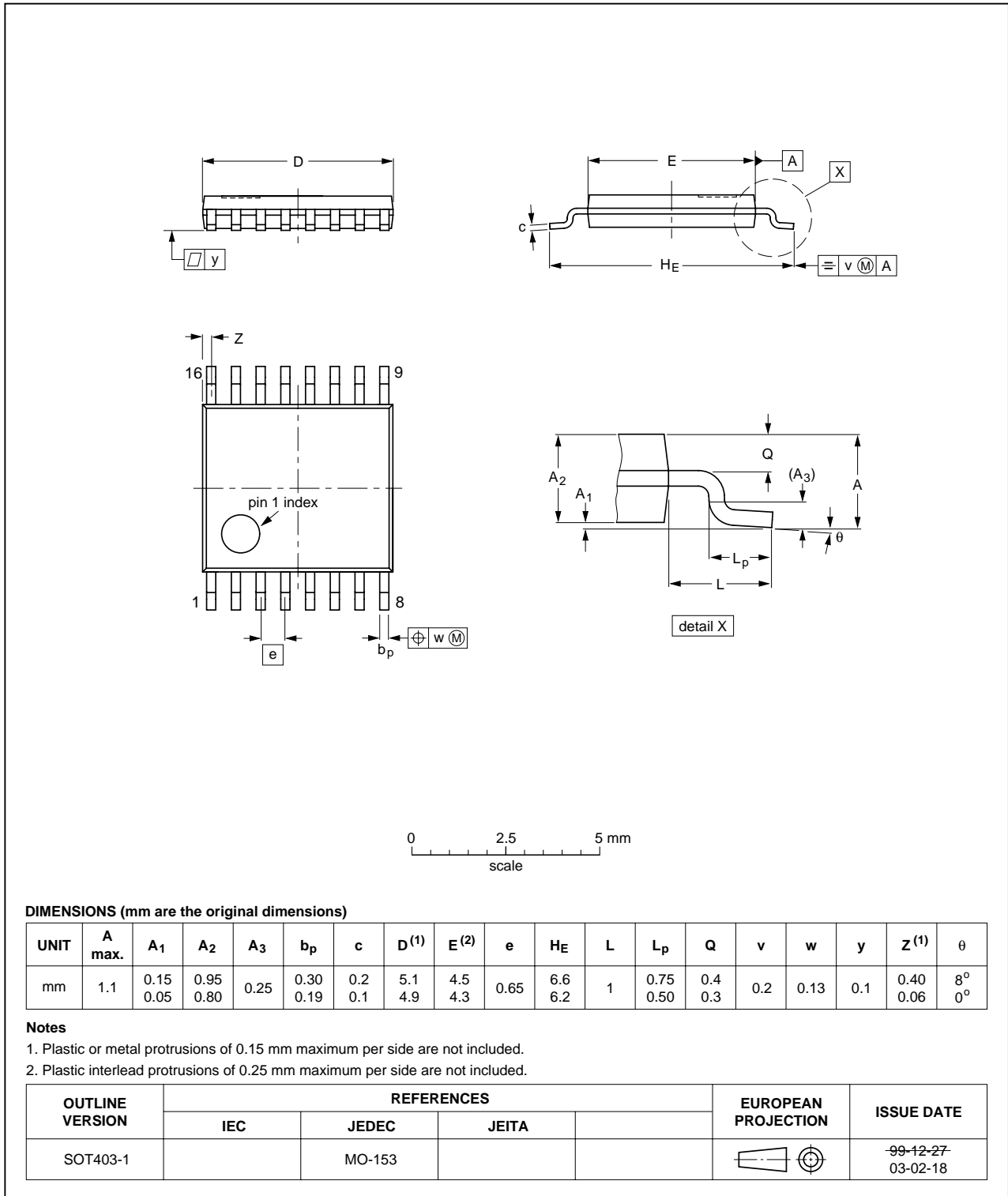


Fig 13. Package outline SOT403-1 (TSSOP16)

13. Abbreviations

Table 11. Abbreviations

| Acronym | Description |
|---------|--|
| CDM | Charged Device Model |
| CMOS | Complementary Metal-Oxide Semiconductor |
| DUT | Device Under Test |
| ESD | ElectroStatic Discharge |
| HBM | Human Body Model |
| LSTTL | Low-power Schottky Transistor-Transistor Logic |
| MM | Machine Model |

14. Revision history

Table 12. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|-----------------|---|-----------------------|---------------|-----------------|
| 74AHC_AHCT259_2 | 20080515 | Product data sheet | - | 74AHC_AHCT259_1 |
| Modifications: | <ul style="list-style-type: none"> The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Legal texts have been adapted to the new company name where appropriate. Table 6: the conditions for input leakage current have been changed. | | | |
| 74AHC_AHCT259_1 | 20000314 | Product specification | - | - |

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15.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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